



DIN 863 T3 (Style D14) NF E 11-090



Meas. element: max. perm. error of 2 µm



Mobile anvil: repeatability limit of 0,5 µm.



Tungsten carbide tipped



Adjustable part support (except model with small measuring faces).



0,5 mm



Anvil: 2 up to 8 N, adjustable



6,5 mm or 2 mm dia. and length of 5 mm for models with small measuring faces.



Vernier reading to 0,002 mm

ETALON MICROSPEL 280

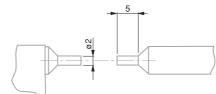
These micrometers have a mobile anvil along with an 8 mm diameter clamping bore for mounting a sensor with linear action such as a TESA GT 21/22 electronic probe. Specially designed for batch inspection of small precision made parts.

















mm 072110816 $0 \div 25$ Standard inserts 072110853 $0 \div 20$ Pointed inserts

Electronic probe and micrometer stand are not part of the delivery scope and must be ordered separately.